

# **TEST REPORT**

- **APPLICANT** : LG Electronics USA, Inc.
- PRODUCT NAME : Smartphone
- MODEL NAME : LM-K310IM
- BRAND NAME : LG
- FCC ID : ZNFK310IM
- STANDARD(S) : 47 CFR Part 15 Subpart B
- **RECEIPT DATE** : 2020-07-01
- **TEST DATE** : 2020-07-02 to 2020-07-03
- **ISSUE DATE** : 2020-08-07

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Edited by:

He Sinuo(Rapporteur) Xîao Xîona

Approved by:

Xiao Xiong(Supervisor)

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SHENZHEN MORLAB COMMUNICATIONS TECHNOLOGY Co., Ltd. FL1-3, Building A, FeiYang Science Park, No.8 LongChang Road, Block67, BaoAn District, ShenZhen , GuangDong Province, P. R. China

Tel: 86-755-36698555 Fax: 86-75

Http://www.morlab.cn

Fax: 86-755-36698525 E-mail: service@morlab.cn





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Change History					
Version Date Reason for Change					
1.0	2020-08-07	First edition			





Note: Provide by applicant

### **1.1. Applicant and Manufacturer Information**

Applicant:	LG Electronics USA, Inc.
Applicant Address:111 Sylvan Ave North Building Englewood Cliffs, New Jersey,	
	United States 07632
Manufacturer:	Padget Electronics Private Limited
Manufacturer Address:	B-18, Phase-2, Noida, Uttar Pradesh 201305

### **1.2. Equipment Under Test (EUT) Description**

Product Name:	Smartphone					
Serial No.:	(N/A, marked #1 by test	t site)				
Hardware Version:	V1.0					
Software Version:	LG_LM-K310IM_Software					
Tx Frequency:	GSM850: 824 MHz ~ 849 MHz					
	GSM1900: 1850 MHz ~	1910 MHz				
	LTE Band 5: 824 MHz ~	- 849 MHz				
	LTE Band 38: 2570 MH	z ~ 2620 MHz				
	LTE Band 40: 2300 MH	z ~2400 MHz				
	LTE Band 41: 2535 MH	z ~ 2655 MHz				
	Bluetooth 4.2: 2402 MH	z ~ 2480 MHz				
	802.11b/g/n: 2412 MHz	~ 2472 MHz				
Rx Frequency:	GSM850: 869 MHz ~ 89	94 MHz				
	GSM1900: 1930 MHz ~ 1990 MHz					
	LTE Band 5: 869 MHz ~ 894 MHz					
	LTE Band 38: 2570 MHz ~ 2620 MHz					
	LTE Band 40: 2300 MHz ~ 2400 MHz					
	LTE Band 41: 2535 MHz ~ 2655 MHz					
	Bluetooth 4.2: 2402 MH	z ~ 2480 MHz				
	802.11b/g/n: 2412 MHz	~ 2472 MHz				
	GPS/Beidou/GLONASS: 1559 MHz ~ 1610 MHz					
	FM: 87.5 MHz ~ 108 MHz					
Ancillary	Battery					
Equipment:	Brand Name: LG					
	Model No.:	LG4000STCL02				



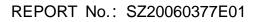


Serial No.:	(N/A, marked #1 by test site)
Capacity:	3900mAh
Rated Voltage:	3.85V
Charge Limit:	4.4V
Manufacturer:	Ningbo Veken Battery Co., Ltd.
AC Adapter	
Brand Name:	N/A
Model No.:	TN-050155U3
Serial No.:	(N/A, marked #1 by test site)
Rated Input:	100-240V ~ 50/60Hz 0.25A
Rated Output:	5V1.55A
Manufacturer:	Shenzhen BMT Electronics Co.,Ltd.
USB Cable	
Model:	DA-B0488-BD
Manufacturer:	Guangdong Wivtak Technology Co., Ltd.

#### Note:

1. For a more detailed description, please refer to specification or user's manual supplied by the applicant and/or manufacturer







## 2.1. Applied Reference Documents

T he objective of the report is to perform testing according to 47 CFR Part 15 Subpart B:

No.	Identity	Identity Document Title	
1	47 CFR Part 15	Radio Frequency Devices	

Test detailed items/section required by FCC rules and results are as below:

No.	Section	Description	Test Date	Test Engineer	Result	Method Determination Remark
1	15.107	Conducted Emission	2020.07.03	Huang Zhiye	PASS	No deviation
2	15.109	Radiated Emission	2020.07.02	Yang Jie	PASS	No deviation

**Note 1:** The tests were performed according to the method of measurements prescribed in ANSI C63.4-2014.

**Note 2:** Additions to, deviation, or exclusions from the method shall be judged in the "method determination" column of add, deviate or exclude from the specific method shall be explained in the "Remark" of the above table.





## 2.2. EUT Setup and Operating Conditions

Note: All of the following test modes are tested in all the test items.

Test Mo	des	5		
Mode 1	:	GSM /LTE Band Idle + Bluetooth Idle + WLAN Idle + GPS Rx + Battery + USB		
		Cable(Charging from Adapter) + Earphone + Adapter + SIM Card		
Mode 2	:	GSM /LTE Band Idle + Bluetooth Idle + WLAN Idle + GLONASS Rx + Battery + USB		
		Cable(Charging from Adapter) + Earphone + Adapter + SIM Card		
Mode 3	:	GSM /LTE Band Idle + Bluetooth Idle + WLAN Idle + Galileo Rx + Battery + USB		
		Cable(Charging from Adapter) + Earphone + Adapter + SIM Card		
Mode 4	:	GSM /LTE Band Idle + Bluetooth Idle + WLAN Idle + Camera + Battery + USB		
		Cable(Charging from Adapter) + Earphone + Adapter + SIM Card		
Mode 5	:	GSM /LTE Band Idle + Bluetooth Idle + WLAN Idle + FM + Battery + USB		
		Cable(Charging from Adapter) + Earphone + Adapter + SIM Card		
Mode 6	:	GSM /LTE Band Idle + Bluetooth Idle + WLAN Idle + PC + Battery + Earphone +		
		USB Cable + SIM Card		
Remark:				
The above test mode in boldface (Mode 4) was the worst case of radiated emission test, only the				
test data	of	the mode was reported. The above test mode in boldface (Mode 6) was the worst		

During the measurement, the environmental conditions were within the listed ranges:

case of conducted emission tests, only the test data of the mode was reported.

Temperature (°C):	15 - 35
Relative Humidity (%):	30 - 60
Atmospheric Pressure (kPa):	86 - 106





## 3. 47 CFR Part 15B Requirements

### 3.1. Conducted Emission

#### 3.1.1. Requirement

According to FCC section 15.107, the radio frequency voltage that is conducted back onto the AC power line on any frequency within the band 150kHz to 30MHz shall not exceed the limits in the following table, as measured using a  $50\mu$ H/50 $\Omega$  line impedance stabilization network (LISN).

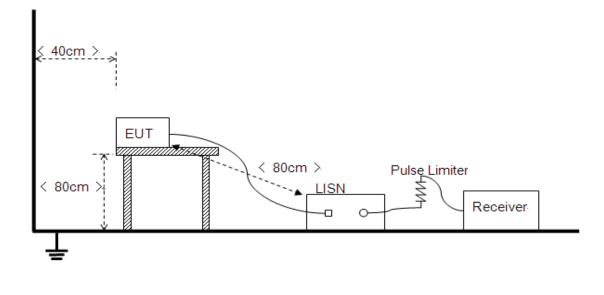
Frequency Range	cy Range Conducted Limit (dBµV)				
(MHz)	Quasi-peak	Average			
0.15 - 0.50	66 to 56	56 to 46			
0.50 - 5	56	46			
5 - 30	60	50			

Note:

- a) The limit subjects to the Class B digital device.
- b) The lower limit shall apply at the band edges.
- c) The limit decreases linearly with the logarithm of the frequency in the range 0.15 0.50MHz.

#### 3.1.2. Test Setup

Please refer to Annex A for the photographs of the Test Configuration.





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 Tel: 86-755-36698555
 Fax: 86-755-36698525

 Http://www.morlab.cn
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The EUT is placed on a 0.8m high insulating table, which stands on the grounded conducting floor, and keeps 0.4m away from the grounded conducting wall. The EUT is connected to the power mains through a LISN which provides  $50\Omega/50\mu$ H of coupling impedance for the measuring instrument. A Pulse Limiter is used to protect the measuring instrument. The factors of the whole test system are calibrated to correct the reading.

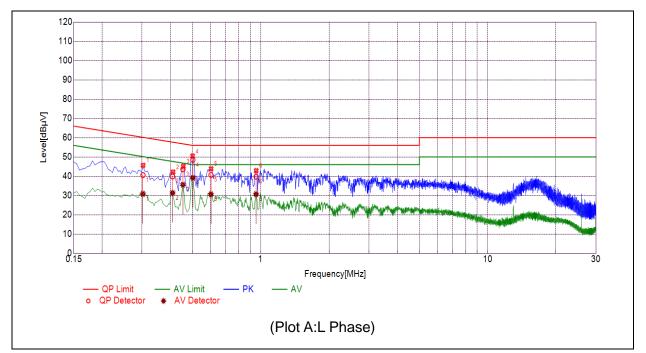
The power strip or extension cord has been investigated to make sure that the LISN integrity inma intained with respect to the impedance characteristics as prescribed in ANSI C63.4-2014 at Clause 4.3.

#### 3.1.3. Test Result

The maximum conducted interference is searched using Peak (PK), Quasi-peak (QP) and Average (AV) detectors; the emission levels more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed. All test modes are considered, refer to recorded points and plots below.



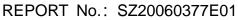


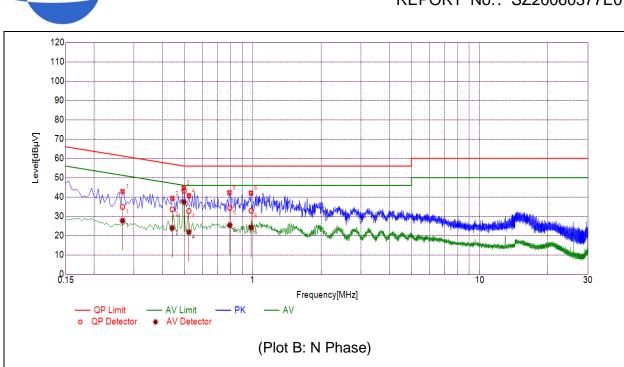


#### A. Test Plot and Suspicious Points:

NO.	Fre.	Emission L	evel (dBµV)	Limit (c	dBμV)	Power-line	Verdict
NO.	(MHz)	Quai-peak	Average	Quai-peak	Average	Power-line	verdict
1	0.3027	40.58	30.84	60.17	50.17	Line	PASS
2	0.4090	39.86	31.31	57.67	47.67		PASS
3	0.4540	43.58	35.59	56.80	46.80		PASS
4	0.5021	48.46	39.14	56.00	46.00		PASS
5	0.6036	40.68	30.61	56.00	46.00		PASS
6	0.9542	39.75	30.73	56.00	46.00		PASS







NO	Fre.	Emission L	evel (dBµV)	Limit (d	dBμV)	Dowor line	Verdict
NO.	(MHz)	Quai-peak	Average	Quai-peak	Average	Power-line	verdict
1	0.2669	34.88	27.71	61.21	51.21	Neutral	PASS
2	0.4417	33.58	23.99	57.03	47.03		PASS
3	0.4981	43.20	37.38	56.03	46.03		PASS
4	0.5231	32.69	21.81	56.00	46.00		PASS
5	0.7928	34.39	25.41	56.00	46.00		PASS
6	0.9842	32.85	24.25	56.00	46.00		PASS



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### 3.2. Radiated Emission

#### 3.2.1. Requirement

According to FCC section 15.109 (a), the field strength of radiated emissions from unintentional radiators at a distance of 3 meters shall not exceed the following values:

Frequency	Field Strength Limitation	at 3m Measurement Dist
Range (MHz)	(μV/m)	(dBµV/m)
30.0 - 88.0	100	20log 100
88.0 - 216.0	150	20log 150
216.0 - 960.0	200	20log 200
Above 960.0	500	20log 500

As shown in FCC section 15.35(b), for frequencies above 1000MHz, the field strength limits are based on average detector. When average radiated emission measurements are specified in this part, including emission measurements below 1000MHz, there also is a limit on the radio frequency emissions, as measured using instrumentation with a peak detector function, corresponding to 20dB above the maximum permitted average limit for the frequency being investigated unless a different peak emission limit is otherwise specified in the rules.

Note:

- 1) The tighter limit shall apply at the boundary between two frequency range.
- 2) Limitation expressed in dB $\mu$ V/m is calculated by 20log Emission Level( $\mu$ V/m).

#### 3.2.2. Frequency Range of Measurement

According to 15.33(b)(1), the frequency range of radiated measurement for the EUT is listed in the following table:

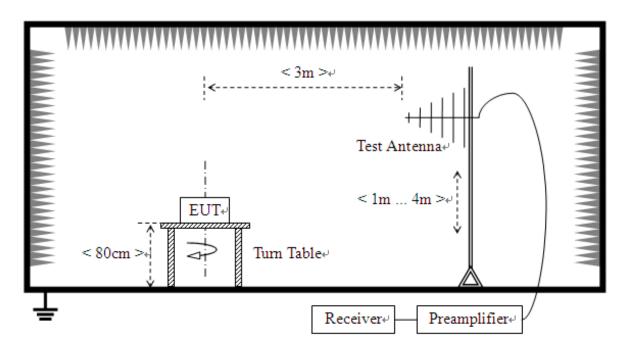
Highest frequency generated or used in the device or on which the device operates or tunes (MHz)	Upper frequency of measure- ment range (MHz)
Below 1.705 1.705–108 108–500 500–1000 Above 1000	30. 1000. 2000. 5000. 5th harmonic of the highest frequency or 40 GHz, whichever is lower.



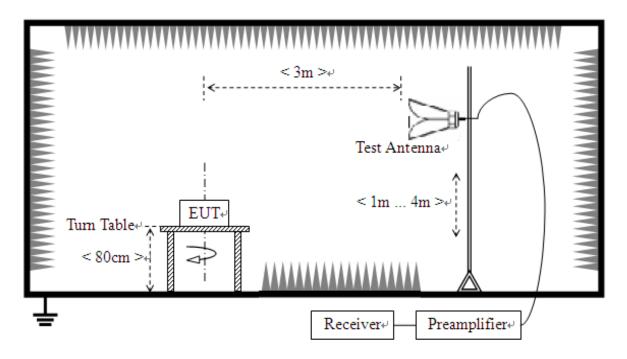


#### 3.2.3. Test Setup

1) For radiated emissions from 30MHz to1GHz



2) For radiated emissions above 1GHz





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The test is performed in a 3m Semi-Anechoic Chamber; the antenna factor, cable loss and so on of the site (factors) is calculated to correct the reading. The EUT is placed on a 0.8m high insulating Turn Table, and keeps 3m away from the Test Antenna, which is mounted on a variable-height antenna master tower.

For the test Antenna:

In the frequency range above 30MHz, Bi-Log Test Antenna (30MHz to 1GHz) and Horn Test Antenna (above 1GHz)are used. Test Antenna is 3m away from the EUT. Test Antenna height is varied from 1m to 4m above the ground to determine the maximum value of the field strength. The emission levels at both horizontal and vertical polarizations should be tested.

#### 3.2.4. Test Result

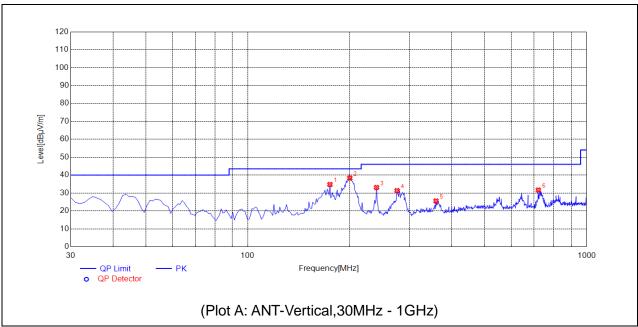
The maximum radiated emission is searched using PK, QP and AV detectors; the emission levels more than the limits, and that have narrow margins from the limits will be re-measured with AV and QP detectors. Both the vertical and the horizontal polarizations of the Test Antenna are considered to perform the tests. All test modes are considered, refer to recorded points and plots below.

The amplitude of emissions (6GHz-13.5GHz) which are attenuated more than 20 dB below the permissible value need not be reported.

Note: All radiated emission tests were performed in X, Y, Z axis direction, and only the worst axis test condition was recorded in this test report.





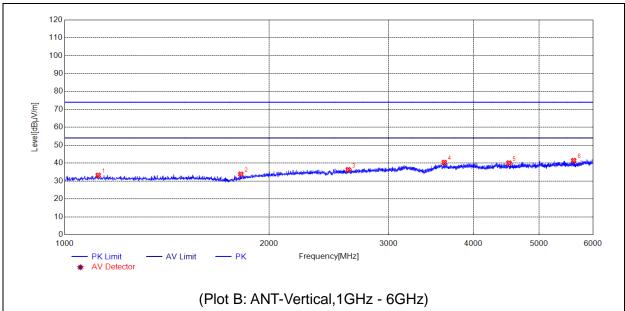


No.	Fre. MHz	PK dBµV/m	QP dBµV/m	AV dBµV/m	Limit-PK dBµV/m	Limit-QP dBµV/m	Limit-AV dBµV/m	ANT	Verdict
1	174.6747	34.75	N.A	N.A	N.A	43.50	N.A	V	PASS
2	199.9199	38.34	N.A	N.A	N.A	43.50	N.A	V	PASS
3	239.7297	33.08	N.A	N.A	N.A	46.00	N.A	V	PASS
4	275.6557	31.33	N.A	N.A	N.A	46.00	N.A	V	PASS
5	359.1592	25.52	N.A	N.A	N.A	46.00	N.A	V	PASS
6	720.3604	31.64	N.A	N.A	N.A	46.00	N.A	V	PASS



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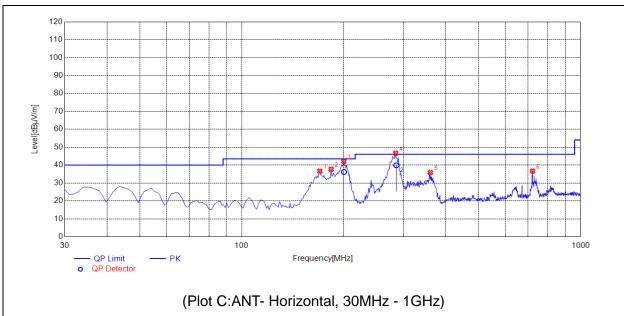


No.	Fre. MHz	PK dBµV/m	QP dBµV/m	AV dBµV/m	Limit-PK dBµV/m	Limit-QP dBµV/m	Limit-AV dBµV/m	ANT	Verdict
1	1120.0240	33.19	N.A	N.A	74.00	N.A	54.00	V	PASS
2	1817.1634	33.77	N.A	N.A	74.00	N.A	54.00	V	PASS
3	2617.3235	36.31	N.A	N.A	74.00	N.A	54.00	V	PASS
4	3624.5249	40.37	N.A	N.A	74.00	N.A	54.00	V	PASS
5	4513.7027	40.05	N.A	N.A	74.00	N.A	54.00	V	PASS
6	5621.9244	41.42	N.A	N.A	74.00	N.A	54.00	V	PASS



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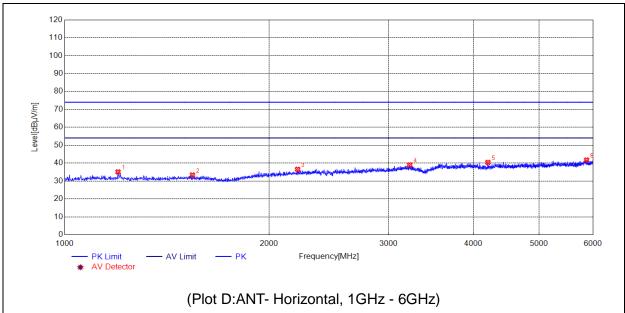




No.	Fre. MHz	PK dBµV/m	QP dBµV/m	AV dBµV/m	Limit-PK dBµV/m	Limit-QP dBµV/m	Limit-AV dBµV/m	ANT	Verdict
1	169.8198	36.61	N.A	N.A	N.A	43.50	N.A	Н	PASS
2	183.4134	37.72	N.A	N.A	N.A	43.50	N.A	Н	PASS
3	199.9199	42.14	36.17	N.A	N.A	43.50	N.A	Н	PASS
4	284.3944	46.62	39.90	N.A	N.A	46.00	N.A	Н	PASS
5	360.1301	35.84	N.A	N.A	N.A	46.00	N.A	Н	PASS
6	721.3313	36.66	N.A	N.A	N.A	46.00	N.A	Н	PASS







No.	Fre. MHz	PK dBµV/m	QP dBµV/m	AV dBµV/m	Limit-PK dBµV/m	Limit-QP dBµV/m	Limit-AV dBµV/m	ANT	Verdict
1	1198.0396	35.10	N.A	N.A	74.00	N.A	54.00	Н	PASS
2	1542.1084	33.38	N.A	N.A	74.00	N.A	54.00	Н	PASS
3	2203.2406	36.53	N.A	N.A	74.00	N.A	54.00	Н	PASS
4	3222.4445	39.01	N.A	N.A	74.00	N.A	54.00	Н	PASS
5	4202.6405	40.40	N.A	N.A	74.00	N.A	54.00	Н	PASS
6	5873.9748	41.73	N.A	N.A	74.00	N.A	54.00	Н	PASS

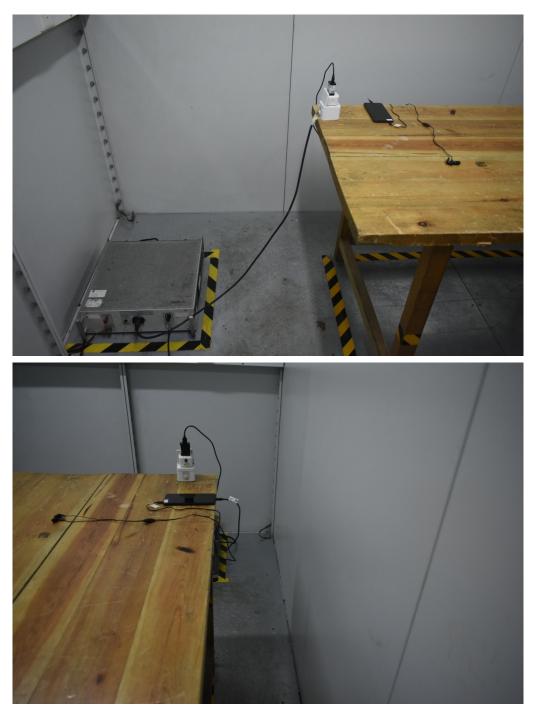


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**Annex A Photographs of Test Setup** 

1. Conducted Emission



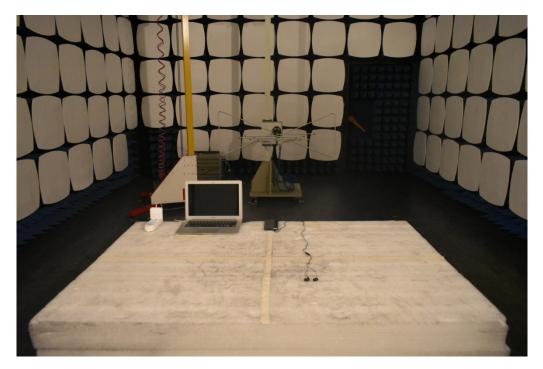
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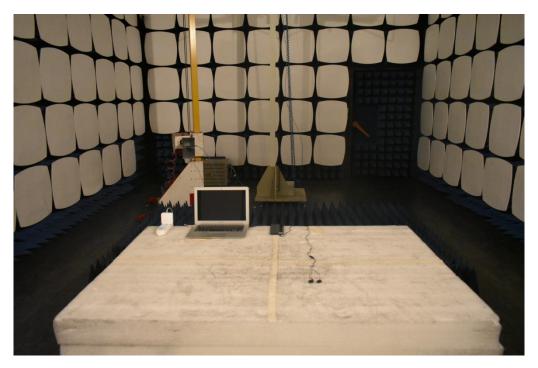
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2. Radiated Emission(30MHz-1GHz)



Radiated Emission(above 1GHz) 3.





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E-mail: service@morlab.cn



## **Annex B Test Uncertainty**

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in Measurement" (GUM) published by ISO.

Uncertainty of Conducted Emission Measurement

Measuring Uncertainty for	9kHz-150kHz	±4.1dB
a Level of Confidence of	150kHz-30MHz	±3.7dB
95%(U=2Uc(y))		

Uncertainty of Radiated Emission Measurement

Measuring Uncertainty for	30MHz-200MHz	±5.06dB
a Level of Confidence of	200MHz-1000MHz	±5.24dB
95%(U=2Uc(y))	1GHz-6GHz	±5.18dB
	6GHz-18GHz	±5.48dB





## **Annex C Testing Laboratory Information**

#### 1. Identification of the Responsible Testing Laboratory

Laboratory Name:	Shenzhen Morlab Communications Technology Co., Ltd.
	Morlab Laboratory
Laboratory Address:	FL.3, Building A, FeiYang Science Park, No.8 LongChang
	Road, Block 67, BaoAn District, ShenZhen, GuangDong
	Province, P. R. China
Telephone:	+86 755 36698555
Facsimile:	+86 755 36698525

#### 2. Identification of the Responsible Testing Location

Name:	Shenzhen Morlab Communications Technology Co., Ltd. Morlab Laboratory	
Address:	FL.3, Building A, FeiYang Science Park, No.8 LongChang Road, Block 67, BaoAn District, ShenZhen, GuangDong Province, P. R. China	

#### 3. Accreditation Certificate

Accredited Testing	The FCC designation number is CN1192.	
Laboratory:	Test firm registration number is 226174.	
	(Shenzhen Morlab Communications Technology Co., Ltd.)	

#### 4. Test Software Utilized

Model	Version Number	Producer		
JS32-RE	Version 2.0.2.0	Tonscend		
TS+ -[ JS32-CE]	Version2.5.0.0	Tonscend		





#### 5. Test Equipments Utilized

Description	Manufacturer	Model	Serial No.	Cal. Date	Due. Date
MXE EMI Receiver	Agilent	N9038A	MY54130016	2019.07.29	2020.07.28
Test Receiver	R&S	ESPI	101052	2019.07.29	2020.07.28
LISN	Schwarzbeck	NSLK 8127	8127449	2020.03.26	2021.03.25
Pulse Limiter (10dB)	Schwarzbeck	VTSD 9561-F	VTSD 9561 F-B #206	2019.08.13	2020.08.12
Test Antenna - Bi-Log	Schwarzbeck	VULB 9163	VULB 9163-519	2019.05.24	2022.05.23
Test Antenna - Horn	Schwarzbeck	BBHA 9120D	9120D-963	2019.05.24	2022.05.23
Test Antenna - Horn	Schwarzbeck	BBHA 9170	BBHA9170#7 73	2019.05.24	2022.05.23
Radiated Disturbance Preamplifier	rflight	S020180L320 3	61171/61172	2019.07.29	2020.07.28
Radiated Disturbance Preamplifier	rflight	S10M100L38 02	46732	2019.07.29	2020.07.28
Semi-Anechoic Chamber	CRT	9m*6m*6m	N/A	2020.01.06	2023.01.05

#### 6. Ancillary Equipment Utilized

Description	Manufacturer	Model	Serial No.
PC	APPLE	A1370	N/A
Adapter	APPLE	A1374	N/A

\_\_\_\_\_ END OF REPORT \_\_\_\_\_

